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United States Patent [19]

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Yau

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[54] INCLINATION MEASURING INSTRUMENT

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[73] Assignee: **Techtronic Industries Co. Ltd., New Territories, Hong Kong**

[**] Term: **14 Years**

[21] Appl. No.: **645,283**

[22] Filed: **Jan. 24, 1991**

[52] U.S. Cl. **D10/65; D10/71**

[58] Field of Search **D10/60, 62, 65, 70, D10/71; 33/335, 336, 337, 471, 483-500**

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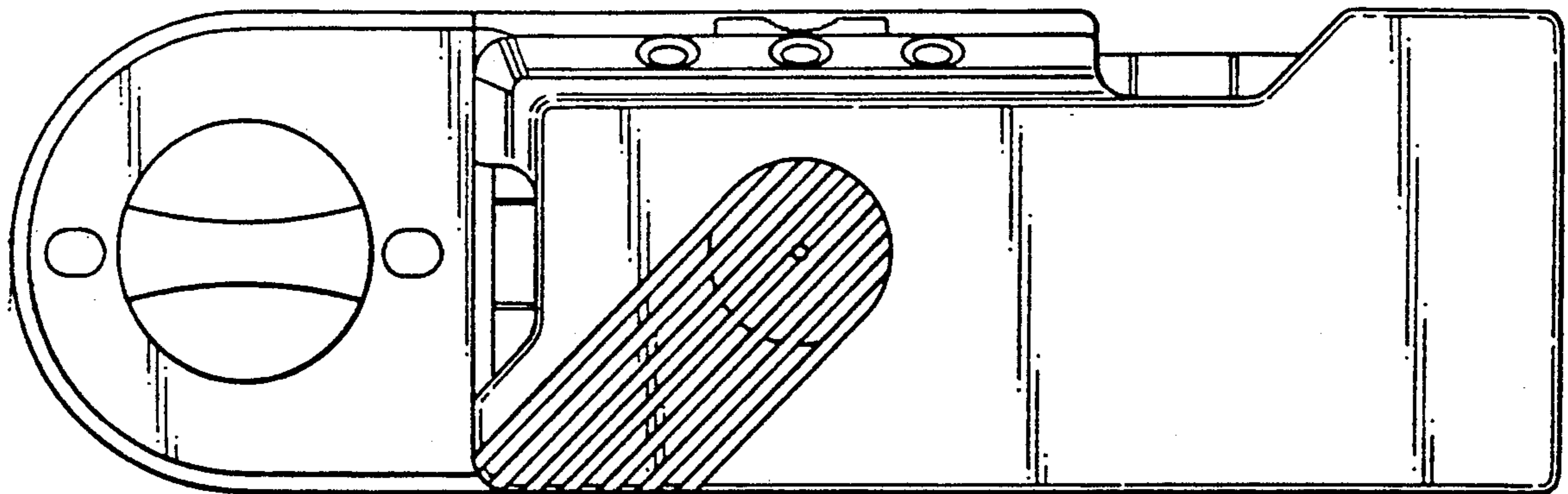
Attorney, Agent, or Firm—Majestic, Parsons, Siebert & Hsue

CLAIM

[57] The ornamental design for an inclination measuring instrument, as shown and described.

DESCRIPTION

FIG. 1 is a front elevational view of an inclination measuring instrument showing my new design; FIG. 2 is a bottom plan view; FIG. 3 is a top plan view; FIG. 4 is a right side elevational view; FIG. 5 is a left side elevational view; and, FIG. 6 is a front elevational view thereof, shown with the ruler element in an alternate condition of use.



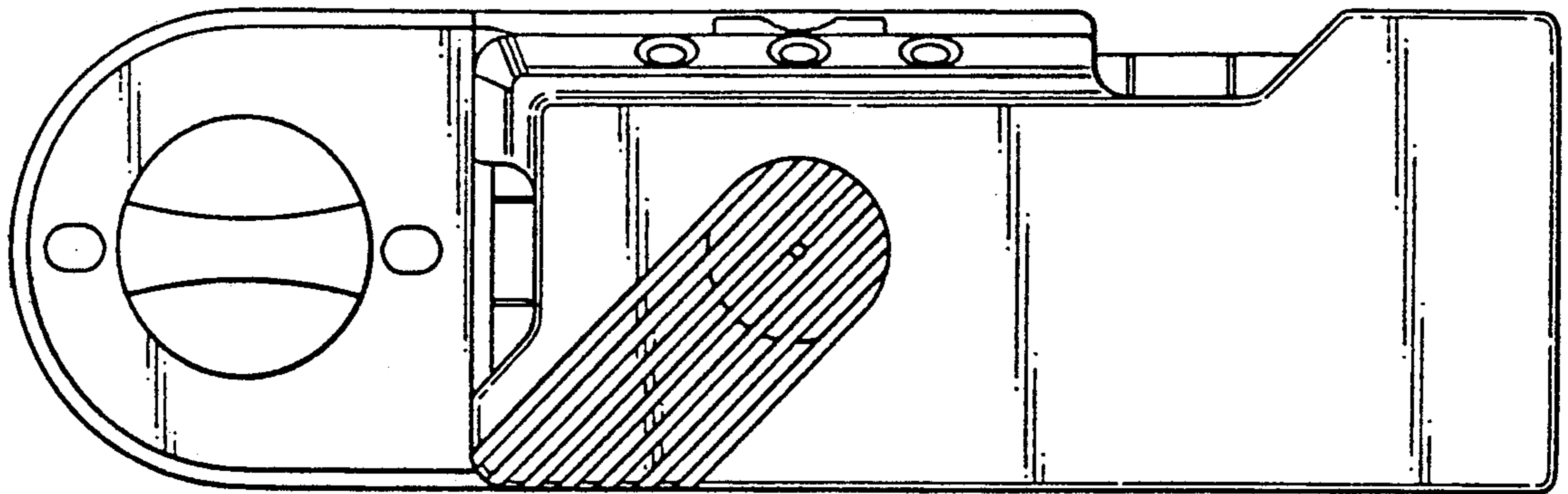


FIG. 1

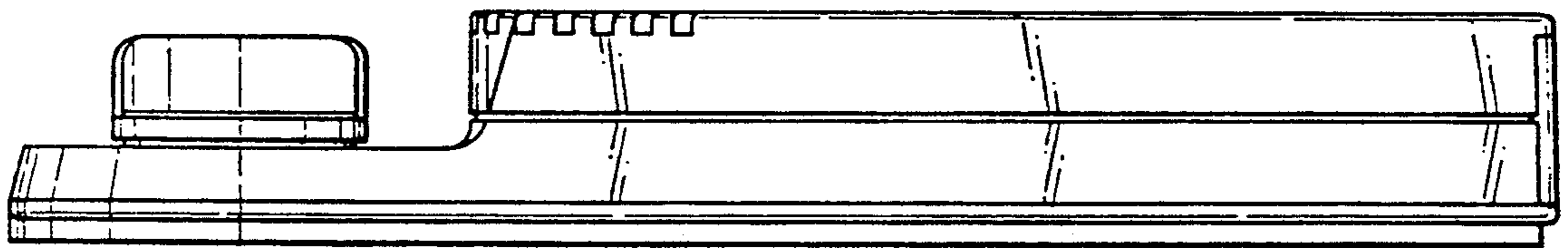


FIG. 2

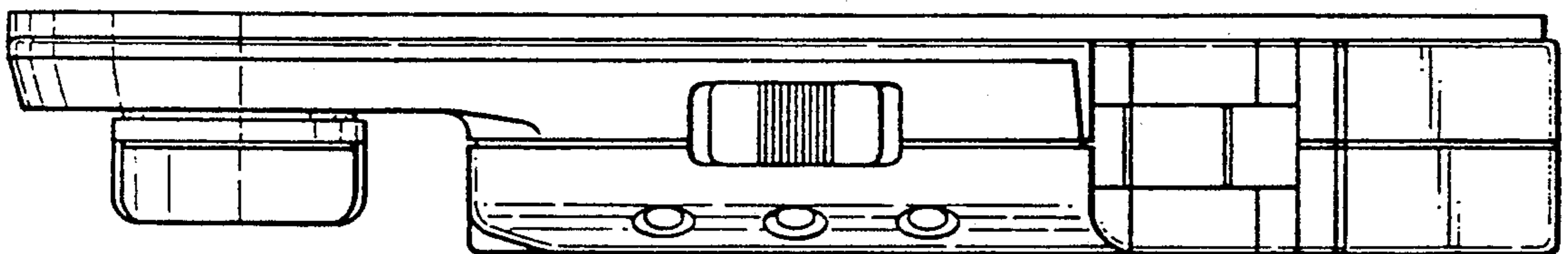


FIG. 3

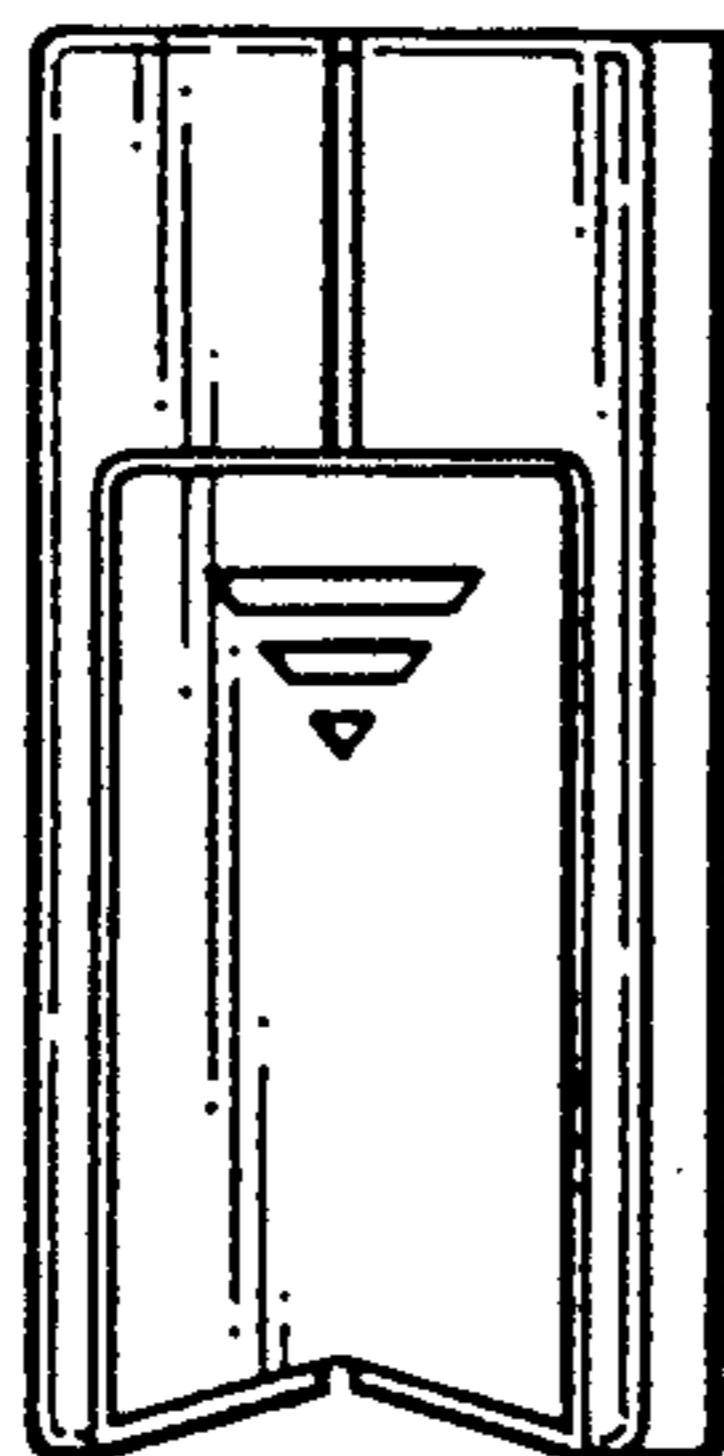


FIG. 4

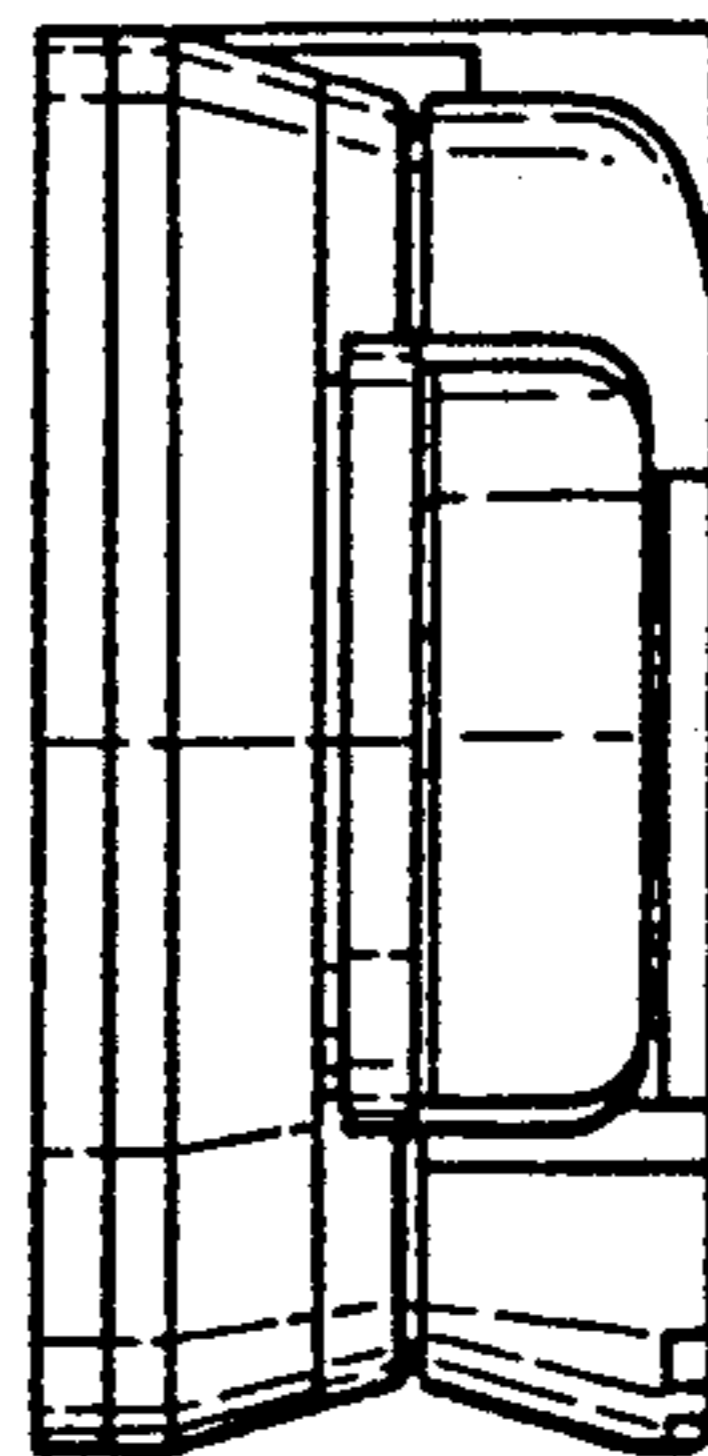


FIG. 5

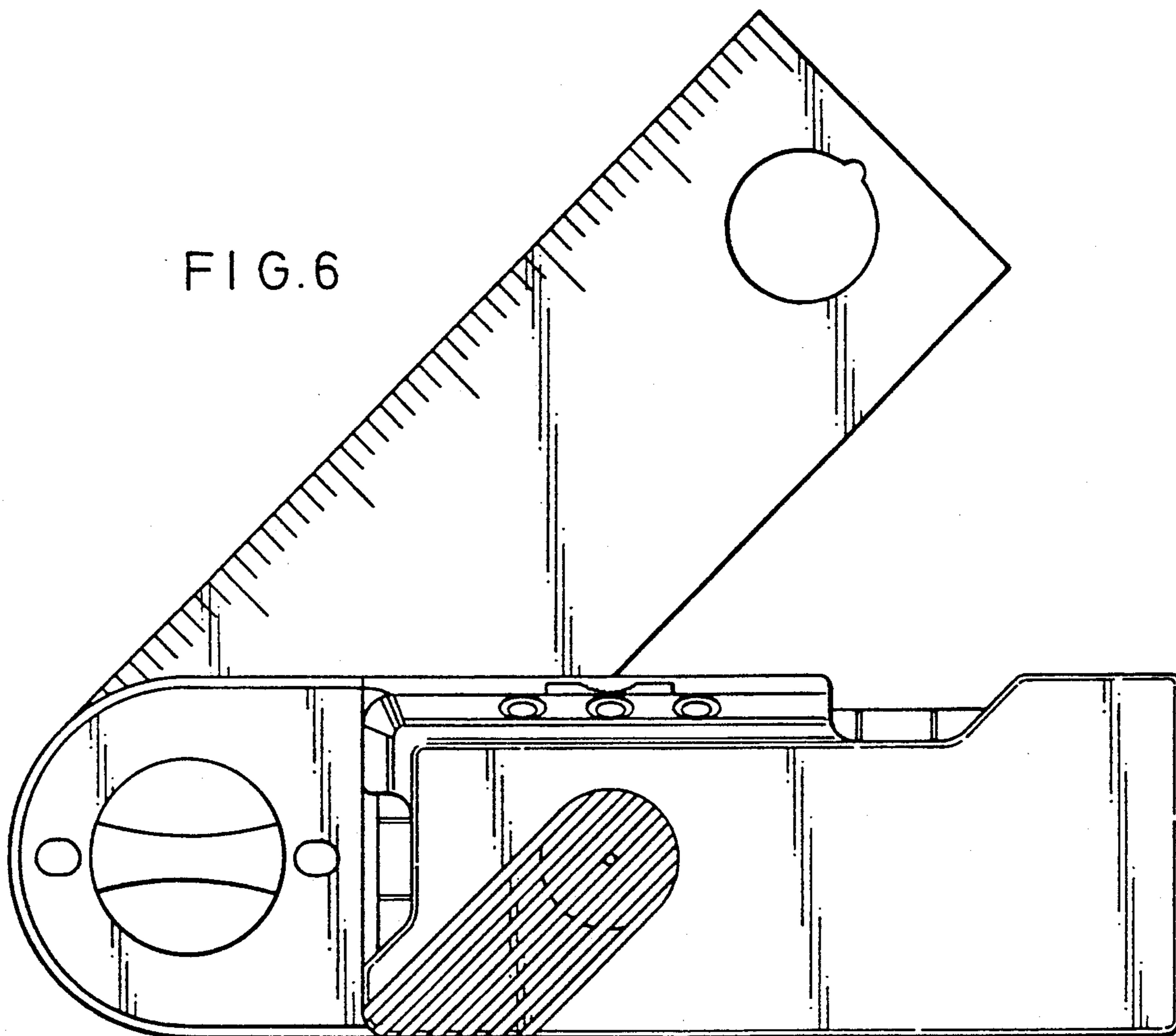


FIG. 6